

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: HEID, Hans, L. et al.) Examiner:
PCT Appl: No.: PCT/EP2003/009856) unknown
PCT Filing Date: September 05, 2003) Art Unit:
For: TEMPERING DEVICE FOR A MICROTOME) unknown

Atty. Docket No.: U195US(PCT)

MAIL STOP PCT

Commissioner for Patents

Alexandria, VA 22313-1450

U.S.A.


INFORMATION DISCLOSURE STATEMENT

The Examiner is referred to the List of Prior Art (Form PTO-1449A).

The applicant assumes that, in accordance with MPEP 1893.03(g), copies of the PCT search document and cited prior art have been forwarded to the USPTO by the European Patent Office. If this is not the case, applicant requests notification of same.



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Enclosures

PTO-Form 1449 (1 page)
Non-PCT references which are
not US Patent Publications

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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<p>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</p> <p>(Use as many sheets as necessary)</p>				Application Number		PCT/EP2003/009856
				Filing Date		PCT September 05, 2003
				First Named Inventor		HEID, Hans, L.
				Group Art Unit		
				Examiner Name		
Sheet	1	of	1	Attorney Docket Number		U195US (PCT)

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines Where Relevant Passage or Relevant Figure Appear
		Number	Kind Code			
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FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Foreign Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
		Office Number	Kind Code			
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		DE	19 62 263	Frigistor	06.15.1967	
		DE	195 28 180	Microm	02.06.1997	
		DE	202 14 646	Microm	11.21.2002	

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